## Harnessing Control of Radiolysis during Liquid Cell Electron Microscopy to Enable Visualization of Nanomaterial Transformation Dynamics

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The radiolysis-induced reduction of dissolved metallic precursor ions or complexes yields formation of metal nanocrystals due to fast reduction reaction kinetics of the precursor with reducing radicals [1]. Liquid cell electron microscopy (LCEM) has offered the opportunity to directly observe radiolysis-induced nanoparticle nucleation and growth *via* high energy electron (200 – 300 keV) irradiation of precursor solutions and simultaneous *in situ* (scanning) transmission electron microscopy ((S)TEM) imaging [2]. However, high electron dose rates associated with (S)TEM imaging result in large yields of both reducing and oxidizing radicals, which leads to uncontrolled synthesis conditions in which there are several competing reactions associated with the formation of metal nanocrystals. To simplify reaction conditions and facilitate quantitative understanding of the reaction kinetics for nanomaterial synthesis, the large pool of radicals formed during radiolysis should be converted into either net reducing or net oxidizing conditions. To this end, we have recently identified a number of reaction environment control parameters for controlling nanomaterial transformation during LCEM, which broadly fall into the categories of electron beam control and chemical control [3].

Here we show that the reaction environment during LCEM can be fine-tuned using a number of solution chemistry and electron beam parameters (Table I). Solution chemistry parameters include radical scavengers, solution pH, and solvent type. Radical scavengers are solutes that act on specific radical species, reacting quickly with these species and eliminating them from the reaction environment. Having a well-defined reaction environment without significant back reactions is highly desirable for synthesis of nanomaterials, especially for understanding fundamental nucleation and growth mechanisms. One specific example is the use of N<sub>2</sub>O to scavenge strongly reducing aqueous electrons to establish a more oxidizing environment containing predominantly hydroxyl radicals. Conversely, alcohols such as isopropanol or ethanol specifically scavenge oxidizing hydroxyl radicals, allowing for a purely reducing environment containing aqueous electrons and hydrogen radicals [4]. Solvent type strongly affects the types and concentrations of radicals formed. For instance, aromatic solvents are relatively resistant to radiation damage and have low radiation yields, which is advantageous for controlling the growth of nanomaterials.

Electron beam parameters include beam current, electron energy, and imaging mode. Rather than controlling the type of radicals formed, these parameters mainly control the amount and location of radicals created during LCEM experiments. Imaging mode (TEM or STEM) has an interesting effect on nucleation and growth of nanoparticles, where empirical evidence suggests that the point electron excitations in STEM quickly exceed the supersaturation condition needed for nucleation to occur, compared to the broad parallel illumination of TEM [5]. We expect these control parameters will provide researchers with a useful toolkit for designing general chemistry and materials science LCEM

experiments by "directing" the effect of the electron beam to understand fundamental nanomaterial transformation mechanisms as well as minimize radiation damage to samples [6].

## References:

- [1] J Belloni, Catalysis Today **113** (2006), pp. 141-156.
- [2] TJ Woehl et a., ACS Nano 6 (2012), pp. 8599-8610.
- [3] TJ Woehl and P Abellan, Journal of Microscopy (2016), Submitted.
- [4] E Sutter et al, Nature Communications 5 (2014).
- [5] P Abellan *et al*, Chemical Communications **50** (2014), pp. 4873-4880.
- [6] SuperSTEM is the UK EPSRC National Facility for Aberration-Corrected STEM, supported by the Engineering and Physical Science Research Council.

Table I. Summary of electron beam and solution chemistry parameters for control of LCEM reaction conditions.

	Radiolysis control parameter	Characteristic effect	Advantages	Disadvantages
Solution Chemistry	Radical scavengers	React specifically and rapidly with certain radicals (e.g. isopronal eliminates OH)	Certain radical species can be eliminated from the pool of primary radicals	Scavenging rate constant must be larger than desired reaction; scavengers must be added at high concentration
	Additives (i.e. halide ions)	Alter oxidizing/reducing power of radicals and molecules <i>via</i> complexing and interconversion reactions	Complexation of metallic ions by halides increases effective oxidizing power of OH; Halides convert OH to more selective oxidizing agents	Require changes to solution chemistry; complexation reactions are only applicable to some noble metals (e.g. Cl- complexes Au and Pt; Br- complexes Pd)
	pH in aqueous solutions (neat water)	Alters concentrations of primary and secondary radicals	More predictable reaction limited nanoparticle growth kinetics at low pH	Require changes to solution chemistry; some reactions require specific pH
	Solvent type (i.e. aqueous, organic, aprotic, aromatic)	Controls the types of primary radicals formed	Control over radical G-values, e.g. aromatics have low G-values for radicals so reactions are controlled by molecular species	
Electron Beam	Electron dose rate	Determines the steady state concentrations of radicals	Requires no chemical additives	No specificity in radiolysis production
	Imaging mode (STEM or TEM)	Controls the how electrons are delivered to the liquid	TEM enables faster image acquisition; STEM only irradiates viewing area and enables better control over dose rate	Some instruments not capable of STEM; TEM imaging often causes bubbles
	Accelerating voltage (neat water)	Effects the electron stopping power and radical G-values	High kV (300 kV) reduces radical G-values due to lower electron stopping power	No specificity in radiolysis production; some TEM instruments do not allow variable kV